SN54AS250A, SN74AS250A 1-OF-16 DATA GENERATORS/MULTIPLEXERS WITH 3-STATE OUTPUTS

SDAS137A - DECEMBER 1983 - REVISED DECEMBER 1994

- 4-Line to 1-Line Multiplexers That Can Select 1-of-16 Data Inputs
- Applications:

Boolean Function Generator Parallel-to-Serial Converter Data Source Selector

- Buffered 3-State Bus Driver Inputs Permit Multiplexing From n Lines to One Line
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (NT) and Ceramic (JT) 300-mil DIPs

description

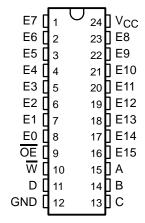
The 'AS250A devices provide full binary decoding to select 1-of-16 data inputs or use sources as an input with an inverting \overline{W} output. The selected sources are buffered with symmetrical propagation delay times. This reduces the possibility of transients occurring at the output.

A buffered output-enable (\overline{OE}) input can be used for n-line to 1-line cascading. Taking \overline{OE} high places the output in the high-impedance state. In the high-impedance state, the output neither loads nor drives the bus lines significantly.

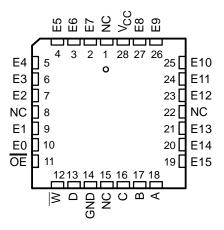
OE does not affect the internal operations of the data selector/multiplexer. New data can be set up while the outputs are disabled.

The SN54AS250A is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74AS250A is characterized for operation from 0°C to 70°C.

SN54AS250A ... JT PACKAGE SN74AS250A ... DW OR NT PACKAGE (TOP VIEW)



SN54AS250A . . . FK PACKAGE (TOP VIEW)



NC – No internal connection



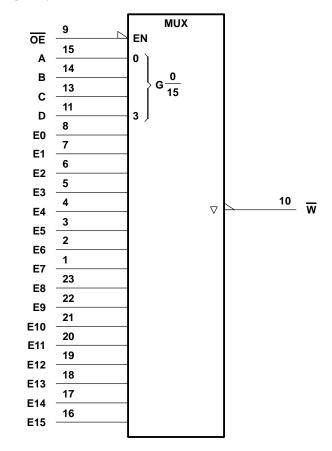
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FUNCTION TABLE

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	INPUTS					OUTPUT			
ŌE	Α	В	С	D	Ei	w			
L	L	L	L	L	E0	E 0			
L	Н	L	L	L	E1	<u>=</u> 1			
L	L	Н	L	L	E2	E2			
L	Н	Н	L	L	E3	E 3			
L	L	L	Н	L	E4	E 4			
L	Н	L	Н	L	E5	E ₅			
L	L	Н	Н	L	E6	E6			
L	Н	Н	Н	L	E7	E7			
L	L	L	L	Н	E8	E8			
L	Н	L	L	Н	E9	E 9			
L	L	Н	L	Н	E10	E 10			
L	Н	Н	L	Н	E11	<u></u> E11			
L	L	L	Н	Н	E12	E12			
L	Н	L	Н	Н	E13	<u>=</u> 13			
L	L	Н	Н	Н	E14	E 14			
L	Н	Н	Н	Н	E15	E15			
Н	X	X	X	Х	Х	Z			

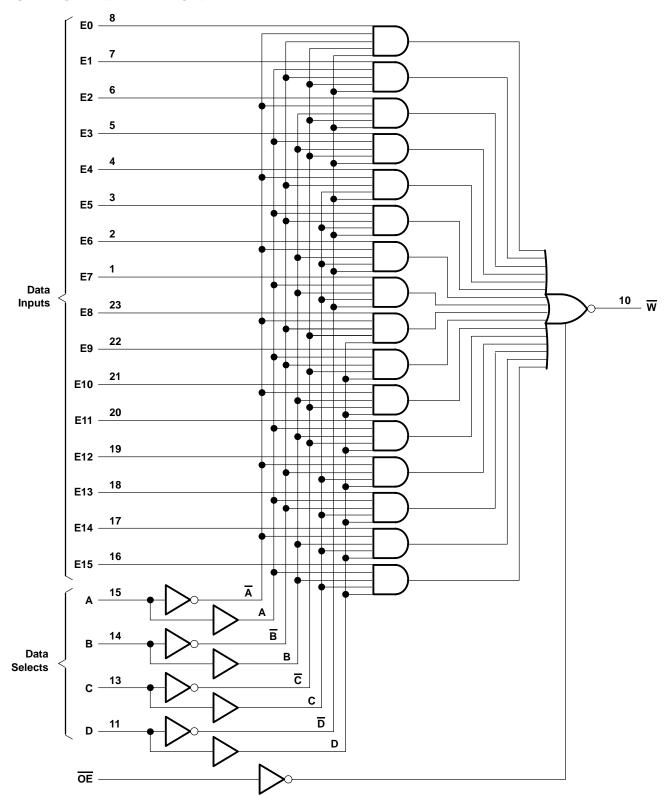
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the DW, JT, and NT packages.

logic diagram (positive logic)



Pin numbers shown are for the DW, JT, and NT packages.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Operating free-air temperature range, T _A : SN54AS250A	55°C to 125°C
SN74AS250A	0°C to 70°C
Storage temperature range	. −65°C to 150°C

recommended operating conditions

		SN54AS250A		SN74AS250A			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	וואוט
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			8.0			0.8	V
IOH	High-level output current			-12			-15	mA
lOL	Low-level output current			32			48	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN	SN54AS250A			SN74AS250A			
PARAMETER			MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V	
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2			
VOH	V _{CC} = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4	3.3					V	
		$I_{OH} = -15 \text{ mA}$				2.4	3.3			
Va	V _{CC} = 4.5 V	$I_{OL} = 32 \text{ mA}$		0.35	0.5				V	
VOL		$I_{OL} = 48 \text{ mA}$					0.35	0.5	l ^v	
lozh	$V_{CC} = 5.5 V$,	V _O = 2.7 V			50			50	μΑ	
lozL	$V_{CC} = 5.5 V$,	$V_0 = 0.4 V$			-50			-50	μΑ	
lį	$V_{CC} = 5.5 V$,	V _I = 7 V			0.1			0.1	mA	
lін	$V_{CC} = 5.5 V,$	V _I = 2.7 V			20			20	μΑ	
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.5			-0.5	mA	
IO§	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA	
	V _{CC} = 5.5 V	Outputs high		26	42		26	42		
ICC		Outputs low		31	50		31	50	mA	
		Outputs disabled		30	48		30	48		

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

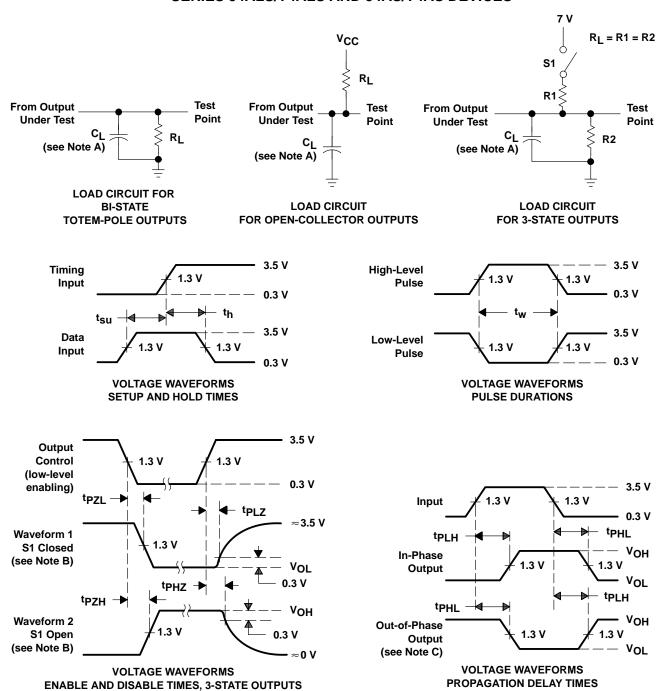
[§] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_A = MIN to MAX [†] SN54AS250A SN74AS250A				UNIT
			MIN	MAX	MIN	MAX	
t _{PLH}	Data	$\overline{\mathbb{W}}$	2	9.5	2	8	ns
t _{PHL}		VV	2	8.5	2	7	115
t _{PLH}	A, B, C, D	$\overline{\mathbb{W}}$	4	15.5	4	13	ns
t _{PHL}		VV	4	12	4	10.5	115
^t PZH	ŌĒ	$\overline{\mathbb{W}}$	2	7.5	2	7	20
t _{PZL}			2	10	2	9	ns
^t PHZ	ŌĒ	$\overline{\mathbb{W}}$	1.5	6.5	1.5	6	nc
t _{PLZ}	OE OE	۷V	2	8.5	2	6.5	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A. C_I includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
 - All input pulses have the following characteristics: PRR \leq 1 MHz, $t_{\Gamma} = t_{f} = 2$ ns, duty cycle = 50%.
 - The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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